S	e	a	rc	h	N	0	te	S
---	---	---	----	---	---	---	----	---



Application/Control No.	Applicant(s)/Patent under Reexamination
10/705,763	CLARK ET AL.
Examiner	Art Unit
Chuck Huynh	2617

	SEARCHED			
Class	Subclass	Date	Examiner	
Updated	Search	6/15/2006	U) Ch	
455	418	6/15/2006	4	
	_			

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	l			

SEARCH NO (INCLUDING SEARCH		')
	DATE	EXMR
Class/Subclass	6/15/2006	Ü
Combined text search: client-server, XSLT, multiple near requests	6/15/2006	91
Look over previous reference	6/15/2006	47
Talked to Eliseo and Tommy Chin	6/21/2006	Gr